A woofer–tweeter adaptive optical structured illumination microscope (AOSIM) is presented. By combining a low-spatial-frequency large-stroke deformable mirror (woofer) with a high-spatial-frequency low-stroke deformable mirror (tweeter), we are able to remove both large-amplitude and high-order aberrations. In addition, using the structured illumination method, as compared to widefield microscopy, the AOSIM can accomplish high-resolution imaging and possesses better sectioning capability. The AOSIM was tested by correcting a large aberration from a trial lens in the conjugate plane of the microscope objective aperture. The experimental results show that the AOSIM has a point spread function with an FWHM that is 140 nm wide (using a water immersion objective lens with $NA = 1.1$) after correcting a large aberration (5.9 μm peak-to-valley wavefront error with 2.05 μm RMS aberration). After structured light illumination is applied, the results show that we are able to resolve two beads that are separated by 145 nm, 1.62× below the diffraction limit of 235 nm. Furthermore, we demonstrate the application of the AOSIM in the field of bioimaging. The sample under investigation was a green-fluorescent-protein-labeled *Drosophila* embryo. The aberrations from the refractive index mismatch between the microscope objective, the immersion fluid, the cover slip, and the sample itself are well corrected. Using AOSIM we were able to increase the SNR for our *Drosophila* embryo sample by 5×. © 2017 Chinese Laser Press

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1. INTRODUCTION

Light microscopy plays an important role in various research domains, in particular for bioimaging [1,2], due to its noninvasive properties and compatibility with *in vivo* imaging. However, three critical limitations often affect the microscope’s performance. One is the well-known diffraction limit, which limits the microscope resolution to about half of the excitation wavelength due to the wave nature of light. The others are depth aberrations and scattering, which are major sources of image degradation, causing a significant loss of resolution and intensity deep into the sample. A major limitation for ballistic photons is the index mismatch between the sample refractive index (RI) and the immersion medium index [3]. In the past decade, many methods that have reached a spatial resolution beyond the diffraction limit have been reported in Refs. [4–6], for example, stimulated emission depletion microscopy [6], photoactivated localization microscopy [4], and structured illumination microscopy (SIM) [7–11]. Among these, SIM, which extracts high-resolution information from aliased raw data in Fourier space, is widely used in bioimaging. The advantages of SIM are that it is compatible with standard dyes and fluorescent proteins and the images are usually taken in widefield mode, so the image acquisition is faster than scanned beam approaches such as confocal and multiphoton microscopy. Concerning the penetration depth, to overcome the poor sectioning properties of linear absorption widefield microscopy, light sheet [12,13], structured illumination (SI) [11,14–16], confocal [2], and multiphoton microscopy [17] have been used. Indeed, as compared to the widefield microscope, the multiphoton microscope is able to image up to 1200 μm deep in samples [18]. However, imaging deep into the sample, the RI mismatch between the objective lens and the sample, and the aberration from the sample itself, often degrades the point spread function (PSF) quality. Instead of having a high-contrast diffraction-limited focal spot, the energy of the light spreads out widely near the focal region. In order to redirect the light into the small focal area where it supposed to be, adaptive optics [19] is vitally important. Using adaptive
optics, the aberration can be compensated in two ways. One way is direct measurement of the aberrated wavefront using a wavefront sensor [e.g., Shack–Hartmann wavefront (SHW) sensor] and feedback to a deformable mirror (DM) to compensate the wavefront error. The wavefront can be measured by either introducing an artificial guide star [20–22] or using a sample that has been labeled with fluorescent proteins [23–25]. Recently, Tao et al. [26], reported the measurement of the wavefront from autofluorescent light from within the sample. In this direct wavefront measurement mode, the DM correction can be done using either a closed-loop or an open-loop control mode. In the former method, the wavefront is continuously measured and fed back to the DM until the corrected wavefront error is below a specified threshold. The closed-loop method has superior correction relative to open-loop correction, but it is time-consuming, since it requires several cycles of correction. The open-loop approach requires a calibrated DM system but is able to make the correction faster because it is done in a single step without iterations. Another method for wavefront correction is a sensorless method [27]. The advantage is that it does not require an additional wavefront sensor in the optical system. By applying different estimated Zernike modes to the DM and using the peak intensity [28] (or average intensity [29], image sharpness [30], or Fourier contents [31]) on a CCD camera as a figure of merit for optimization, it is possible to iteratively optimize the aberration and make the correction. Indeed, it requires less optical instrumentation; however, it is time-consuming. It is not suitable for a live imaging environment with rapidly changing wavefront errors.

The benefits of adaptive optics applied to several types of light microscopy have been reported. Examples include adaptive optical (AO) confocal microscopy [19,32], AO two-photon microscopy [26,29], and AO SIM [28,33,34]. AO correction provides better resolution, SNR, and contrast, and enables a deeper penetration depth. Recently, Thomas et al. [28] reported on the application of AO to SIM. In their wavefront sensorless system, a DM, the Mirao 52-e from Imagine Optics, was employed to compensate the wavefront aberration. Imaging a fluorescent nanoparticle under a 35 μm thick C. elegans worm, a 140 nm FWHM of the PSF was reported in their results after AO correction.

Although a high Strehl ratio of 0.8 was obtained after AO correction of the aberration caused by the C. elegans (rod shape), a drawback of this system is that it is not able to correct high-spatial-frequency aberrations, since the DM that was used (Mirao 52-e) has only 52 actuators (only 36 of the actuators are in the 15 mm effective aperture). This DM can correct high-amplitude wavefront error but not high-order (>6th Zernike) wavefront error. The sensorless mode for wavefront correction also may not be suitable for a sample with dynamic aberrations.

To overcome the previously discussed light microscopy limitations, Chen et al. [35] introduced a dual-DM adaptive optical system into a confocal microscope to enable high-order, high-amplitude wavefront correction and showed improvements in the dynamic range and quality of the wavefront correction for images of the human retina. In our work, we have introduced a dual-DM (woofer–tweeter) adaptive optical system into a widefield SI microscope (AOSIM). The benefit from the dual-DM configuration is the ability to compensate both large-amplitude and high-spatial-frequency wavefront aberrations to enable SIM in thick specimens. After correcting the wavefront aberration, the near-diffraction-limited PSF is further decreased by using the SI method. This paper is organized as follows. First, the woofer–tweeter AOSIM system design is presented. Then the AOSIM is characterized using 0.11 μm fluorescent beads as a target. The AOSIM is then tested by imaging the green fluorescent protein (GFP)-tagged dendrite of an anterior corner cell (ACC) in the Drosophila embryo. In the last section, there are discussions and conclusions for the work.

2. SYSTEM DESIGN

A. Woofer–Tweeter Dual-DM Adaptive Optical System

As schematically illustrated in Fig. 1, the dual-DM woofer and tweeter are placed sequentially in planes conjugated to the back pupil of the objective lens. The “tweeter,” a microelectromechanical systems DM from Boston Micromachines, has 140 actuators with a maximum stroke of 3.5 μm. It is set to correct low-amplitude but high-spatial-frequency wavefront errors. The “woofer,” a membrane DM (Mirao 52-e) from Imagine Optics, has 52 actuators with a maximum stroke of 50 μm. It is designed to correct the low-spatial-frequency but high-amplitude wavefront errors. In order to be suitable for live imaging, we utilized a fast direct wavefront measurement system known as the SHW sensor [36] that includes a 44 × 44 lenslet array (97 of them are in the active aperture) and an electron-multiplying CCD (EMCCD) camera (Andor iXon, 1004 × 1002 pixels). The number of lenslets is approximately the same as the maximum number of Zernike modes that can be corrected (Section 3.2 of Ref. [37]). Each lenslet has a focal length of 24 mm and is placed on a pitch of 0.328 mm to form the array. As shown in Fig. 1, the SHW sensor is placed at the conjugate plane of the back aperture of the objective lens. For the wavefront measurement, we made an artificial guide star by turning on 10 of the center pixels of the digital light projector (DLP). The microscope objective is an Olympus LUMFLN 60 (NA = 1.1, water immersion lens, working distance = 1.5 mm). The series of 2 in. (5.08 cm) lenses, f1 through f5, are placed to readjust the beam size from 6.6 mm after the objective to match the different aperture sizes for the tweeter (4.4 mm) and the woofer (15 mm). The precalibrated woofer and tweeter are both under open-loop control.

B. SIM

In the SI method, to gain a higher-resolution image in comparison to widefield microscopy, additional images are taken at different angles and phases with patterned excitation [7,38]. In the case of 2D SIM, typically nine images are required. Details of our SIM approach can be found in our previous work [39]. In generating fine structured light patterns in the focal plane, the conventional interference method often suffers from mechanical drifting of the diffraction grating and a low frame rate due to the requirement for mechanical motion of the grating. Instead of generating the SI pattern using a mechanical grating, here a DLP with 608 × 684 micromirrors (DLP3000 from Texas Instruments) is used to directly generate
the SI pattern [28,40,41]. The bandwidth of the DLP is 4 kHz. The laser beam is spatially and temporally decorrelated by a spinning ground glass disk (before the DLP) to prevent unwanted speckle patterns. A flip mirror was introduced before the Andor iXon EMCCD camera to direct the light to either the CCD camera or the SHW sensor. To get the maximum SI spatial resolution at the focal plane, we set the DLP to 3 pixels per line. In the SI method, the phase and frequency of the SI pattern is very sensitive to aberrations. RI mismatch or sample aberration will cause unclear fringes in the focal plane.

3. SYSTEM CHARACTERIZATION AND TESTING

The AOSIM system is characterized and tested by imaging 0.11 μm fluorescent beads [FluoSpheres carboxylate-modified microspheres, 0.11 μm, yellow-green fluorescent (505/515)]. The diluted fluorescent beads are sandwiched between a slide and coverslip (#1.5). To maximize the aberration effect at the focal plane of $f_1$ and $f_2$, the common path of excitation and emission light, a trial lens (cylinder) is introduced. The introduced aberration is conjugated to the back pupil of the microscope objective. To measure the wavefront, we turn a few DLP mirror segments (10) to the “on” state to selectively excite a bead in this small area. The wavefront of this “guide star” is measured by the SHW sensor after flipping the mirror (FM). From the measured wavefront, we analyzed the wavefront error up to the 22nd Zernike mode, the root mean square (RMS) wavefront error, the peak-to-valley (P-V) wavefront error, and the Strehl ratio [37,42] (a ratio of the measured PSF intensity to its ideal theoretical predicted PSF intensity).

As shown in Fig. 2(a), due to the strong aberration introduced by the trial lens, without AO compensation, the fluorescent beads are not resolved. The corresponding reconstruction images using SIM, as shown in Fig. 2(e), also do not show any improvement. This is due to the fact that the aberration distorts the SI pattern of the focal plane. The reconstruction algorithm cannot detect any stripe modulation signal in Fourier space. As shown in Table 1, without AO correction (both DMs are in the stop state), the distorted wavefront of Fig. 2(a) has a P-V wavefront error of 8.93 waves (5.9 μm) and an RMS wavefront error that is up to 2.05 waves. In this case, the Strehl ratio is only 0.06. The values of the Zernike modes of the wavefront are shown in Fig. 3 (blue bar). Zernike mode 6, which represents the vertical astigmatism, is dominant in this wavefront aberration. This is well matched to the wavefront error of the introduced trial lens (cylinder). Note that the first four Zernike modes reflect piston, tip–tilt, and focus, which are not wavefront errors. Throughout our investigations, we did not correct these modes using AO. Figures 2(b) and 2(f) show images of 0.11 μm beads after using the woofer to compensate the low-order wavefront aberration (5th–8th Zernike modes). The SNR is significantly improved, and the beads are visible in the images. As also shown in Table 1, in this case, by compensating the low-order high-amplitude aberration, the P-V of the wavefront error decreases from 8.93 to 0.75 waves. However, the resolution of the 0.11 μm beads has not reached the diffraction limit, and the image quality is not improved using SI. This is because we are only correcting the low-order aberrations. The residual aberrations, which have RMS wavefront errors around 0.18, limit the Strehl ratio to 0.27, which is much lower than the diffraction limit (Strehl ratio > 0.8 [42]). If only the tweeter is used to correct the whole aberration, due to its low stroke (maximum of 3.5 μm), the large-amplitude aberration cannot be compensated, as shown in Table 1. The residual aberrations still have a P-V wavefront error around 2.3 waves.
The lower correction capability when using only the tweeter system leads to an RMS wavefront error of 0.46 and a Strehl ratio that is only 0.06. This limited correction capability can also be seen clearly in the images shown in Figs. 2(c) and 2(g). With wavefront correction from both the woofer and tweeter, as shown in Fig. 2(d), the wavefront error caused from the trial lens is well corrected and the 0.11 μm fluorescent beads are diffraction limited. Here, the first four Zernike modes are corrected by the woofer and the rest of the Zernike modes are corrected by the tweeter. After correction by the woofer–tweeter system, the P-V wavefront error is down to only 0.36 waves and has a very low RMS wavefront error (0.08 waves). As shown in Fig. 3, a comparison of AO compensation with and without woofer–tweeter correction, most of the Zernike modes are dramatically decreased after AO compensation. Furthermore, as shown in Fig. 4, the line profile plot of areas 1 and 2 in Figs. 2(d) and 2(h), with SI, compared to widefield only (black line), the two beads that are separated by around 145 nm are just resolved, demonstrating the ability to resolve two beads that are separated by a distance that is less than the Dawes diffraction limit.

The measured size of a bead under widefield and AOSIM is 235 and 140 nm, respectively. With AOSIM, the FWHM of a bead is decreased by a factor of \(1.68\). In this experiment, most of the aberration is compensated by the woofer–tweeter system. The Strehl ratio is increased from 0.06 up to 0.75.

We also tested AOSIM imaging through a Drosophila embryo. The results are shown in Fig. 5. Without AO correction [Fig. 5(a)], the cell bodies and dendrites of the aCC and RP2 motoneurons are blurry. The Zernike mode of the wavefront error is shown in Fig. 6. The aberration is mainly caused by the RI mismatch between the cover slip (#1.5 coverslip

### Table 1. Analysis of Measured Wavefront of Figs. 2(a)–2(d)*

<table>
<thead>
<tr>
<th>No AO</th>
<th>Woofer (W)</th>
<th>Tweeter (T)</th>
<th>Both W and T</th>
</tr>
</thead>
<tbody>
<tr>
<td>P-V (waves)</td>
<td>8.93</td>
<td>0.75</td>
<td>2.31</td>
</tr>
<tr>
<td>RMS (waves)</td>
<td>2.05</td>
<td>0.18</td>
<td>0.46</td>
</tr>
<tr>
<td>Strehl ratio</td>
<td>0.06</td>
<td>0.27</td>
<td>0.08</td>
</tr>
</tbody>
</table>

*Emission wavelength, 0.515 μm.

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RI: 1.5), the mounting medium (Fluoreomount G RI: 1.4),
and the sample. With dual DM compensation, the images
[Fig.5(b)] show that the fluorescent signal is increased up
to 5 times in comparison to the image without AO correction
[Fig.5(e), green line versus black line]. After correction, the
Strehl ratio is up to 0.85, which is much larger than before
correction (0.50). Furthermore, using the SIM method, the
red line in Fig.5(e) shows that the detailed structure of the
dendrites that sprouted from the axon [43] is well resolved.

4. DISCUSSION AND CONCLUSIONS

We have demonstrated that the combination of woofer–tweeter
adaptive optics and SIM can correct high-amplitude low-
spatial-frequency and low-amplitude high-spatial-frequency
wavefront aberration and provides high-contrast high-resolution
images. The experimental results showed that the system can
correct large aberrations (P-V: 8.93 waves). As compared to
the widefield microscope, the SI method allowed two beads that
are separated by 145 nm to be resolved, 1.62× below the dif-
fraction limit of 235 nm. The resolution improvement is a bit
lower than the ideal case of 2. In a highly aberrated or strongly
scattering sample, the contrast of the SI pattern in the image
plane degrades as the spatial frequency of the light approaches
the cutoff frequency of the objective lens. In our experiment,
the spatial frequency of the stripes is a bit lower than the cutoff
frequency of the objective lens to ensure having high-contrast
stripes in the focal plane.

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